## Search Notes



	Applicant(s)/Patent Under Reexamination
10570045	TAKAYAMA ET AL.

3679

Examiner Art Unit

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## **SEARCHED**

Class	Subclass	Date	Examiner
403	24, 26	1/11/10	EG
428	546, 548, 567, 569, 615, 660, 663, 674,675, 676, 677	1/11/10	EG
	Updated Above	9/7/2010	VLM
	Updated Above	7/12/2011	VLM
384	279, 902	7/12/2011	VLM

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted Michael Lavilla for class 428	1/11/10	EG
East Search	7/12/2011	VLM
Consulted Thomas Hannon for class 384	7/12/2011	VLM

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/E. G./ Examiner.Art Unit 3679	

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